

# DATA SHEET

## **BLF245** VHF power MOS transistor

Product specification

September 1992

# VHF power MOS transistor

# BLF245

### FEATURES

- High power gain
- Low noise figure
- Easy power control
- Good thermal stability
- Withstands full load mismatch.

### DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS transistor designed for large signal amplifier applications in the VHF frequency range.

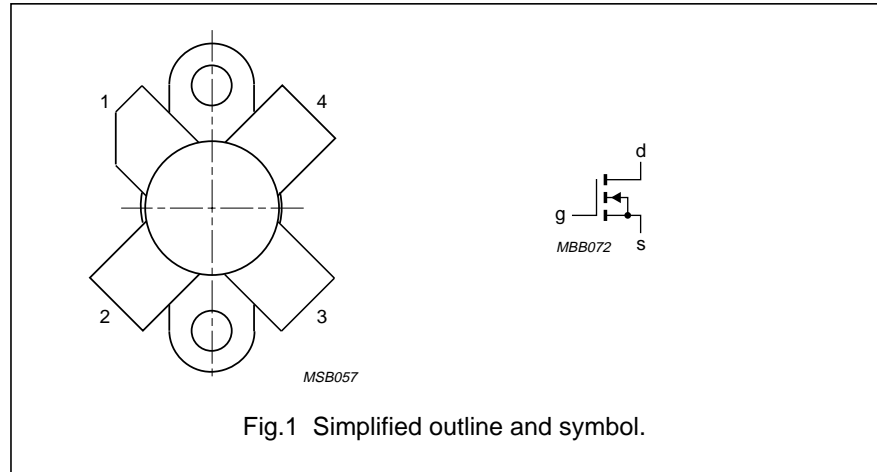
The transistor is encapsulated in a 4-lead SOT123 flange envelope, with a ceramic cap. All leads are isolated from the flange.

Matched gate-source voltage ( $V_{GS}$ ) groups are available on request.

### PINNING - SOT123

PIN	DESCRIPTION
1	drain
2	source
3	gate
4	source

### PIN CONFIGURATION



### CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static charge during transport and handling.

### WARNING

#### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

### QUICK REFERENCE DATA

RF performance at  $T_h = 25\text{ }^\circ\text{C}$  in a class-B test circuit.

MODE OF OPERATION	f (MHz)	$V_{DS}$ (V)	$P_L$ (W)	$G_p$ (dB)	$\eta_D$ (%)
CW, class-B	175	28	30	> 13	> 50

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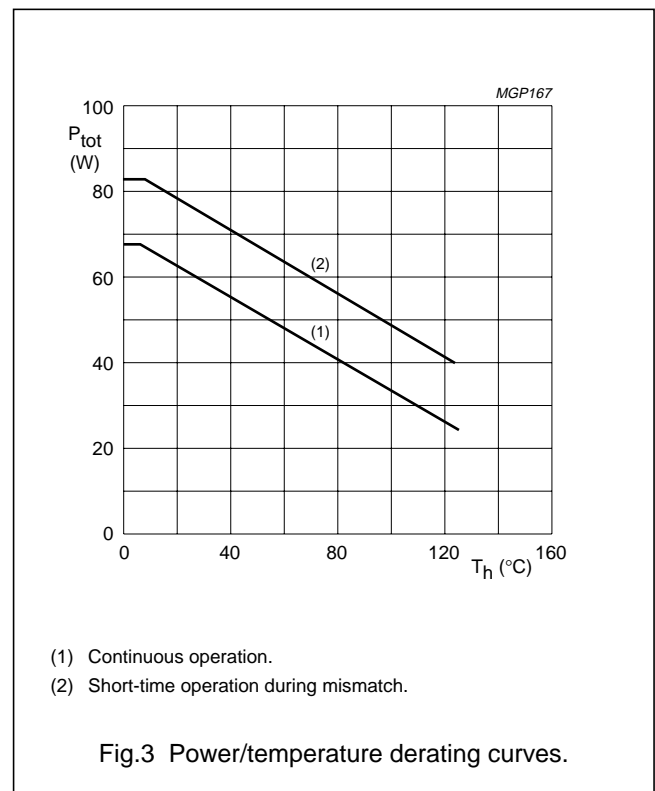
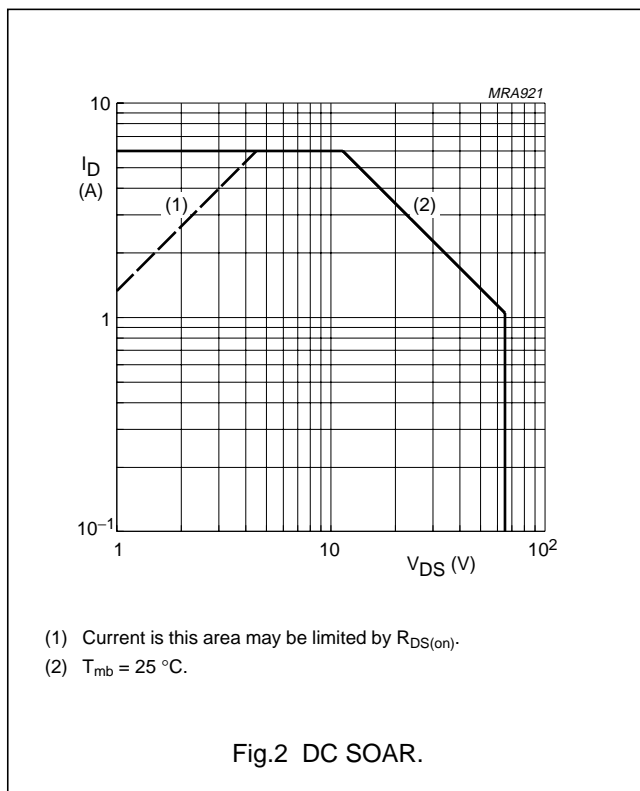
## LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	drain-source voltage	$V_{GS} = 0$	–	65	V
$\pm V_{GS}$	gate-source voltage	$V_{DS} = 0$	–	20	V
$I_D$	DC drain current		–	6	A
$P_{tot}$	total power dissipation	up to $T_{mb} = 25\text{ }^\circ\text{C}$	–	68	W
$T_{stg}$	storage temperature		–65	150	$^\circ\text{C}$
$T_j$	junction temperature		–	200	$^\circ\text{C}$

## THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE
$R_{th\ j-mb}$	thermal resistance from junction to mounting base	$T_{mb} = 25\text{ }^\circ\text{C}; P_{tot} = 68\text{ W}$	2.6 K/W
$R_{th\ mb-h}$	thermal resistance from mounting base to heatsink	$T_{mb} = 25\text{ }^\circ\text{C}; P_{tot} = 68\text{ W}$	0.3 K/W



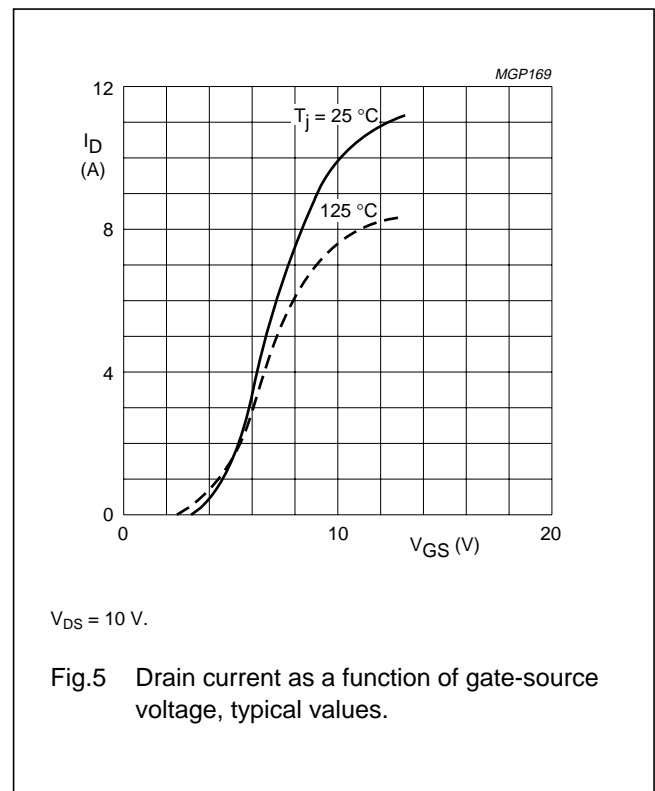
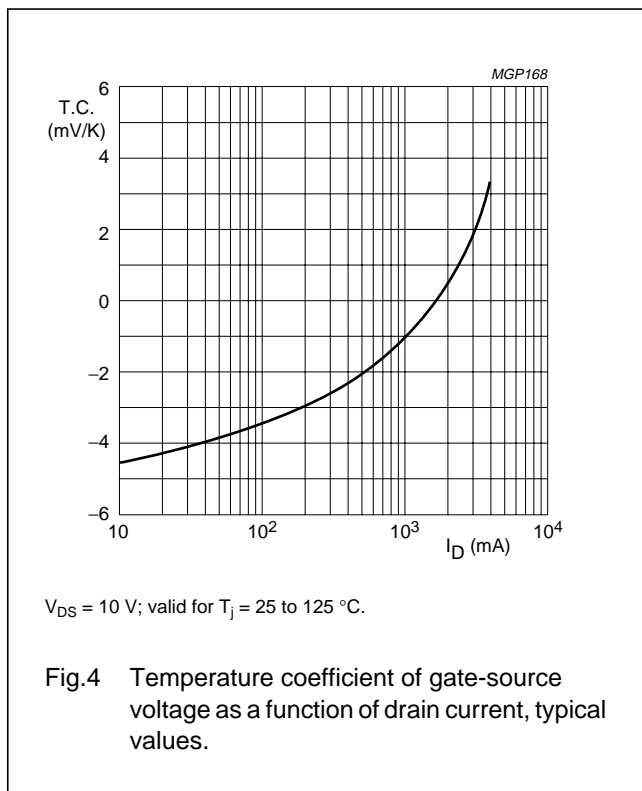
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**CHARACTERISTICS**

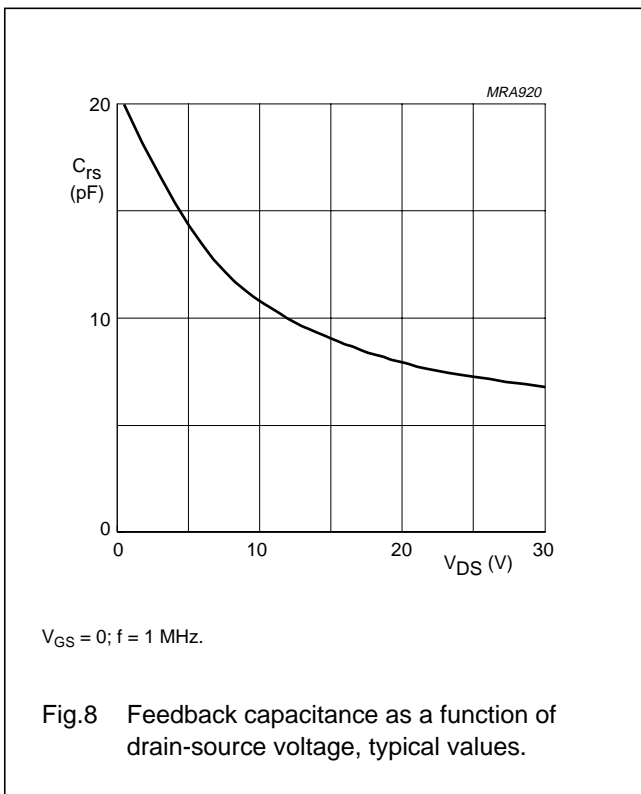
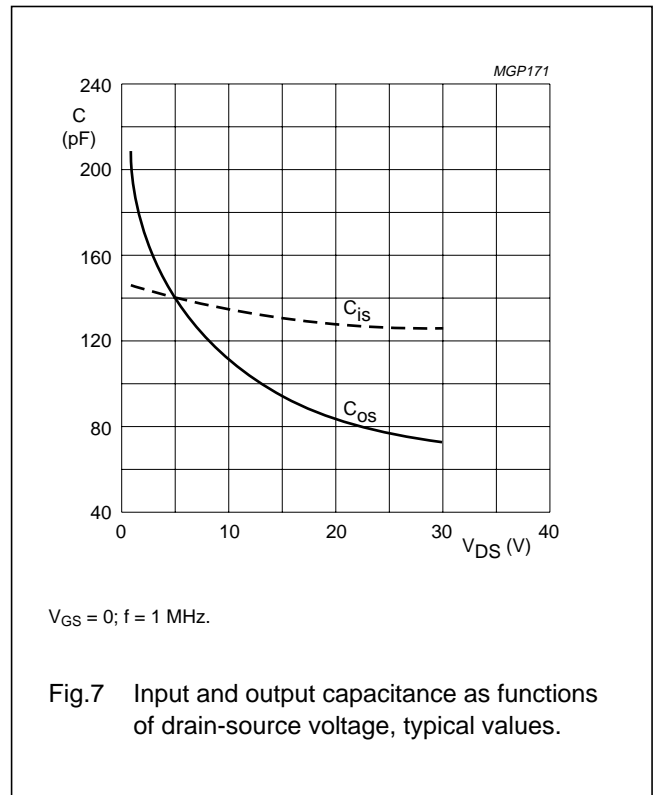
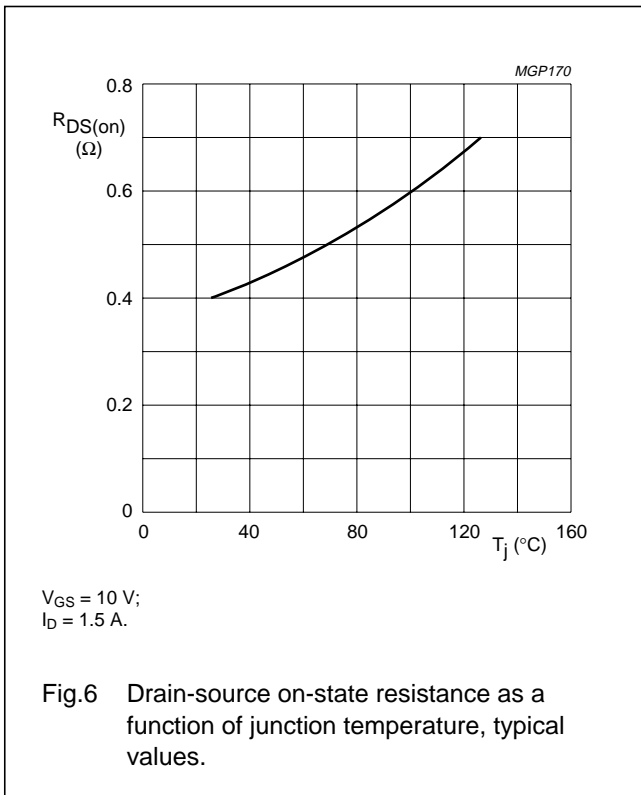
$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0; I_D = 10\text{ mA}$	65	–	–	V
$I_{DSS}$	drain-source leakage current	$V_{GS} = 0; V_{DS} = 28\text{ V}$	–	–	2	mA
$I_{GSS}$	gate-source leakage current	$\pm V_{GS} = 20\text{ V}; V_{DS} = 0$	–	–	1	$\mu\text{A}$
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 10\text{ mA}; V_{DS} = 10\text{ V}$	2	–	4.5	V
$\Delta V_{GS}$	gate-source voltage difference of matched devices	$I_D = 10\text{ mA}; V_{DS} = 10\text{ V}$	–	–	100	mV
$g_{fs}$	forward transconductance	$I_D = 1.5\text{ A}; V_{DS} = 10\text{ V}$	1.2	1.9	–	S
$R_{DS(on)}$	drain-source on-state resistance	$I_D = 1.5\text{ A}; V_{GS} = 10\text{ V}$	–	0.4	0.75	$\Omega$
$I_{DSX}$	on-state drain current	$V_{GS} = 10\text{ V}; V_{DS} = 10\text{ V}$	–	10	–	A
$C_{is}$	input capacitance	$V_{GS} = 0; V_{DS} = 28\text{ V}; f = 1\text{ MHz}$	–	125	–	pF
$C_{os}$	output capacitance	$V_{GS} = 0; V_{DS} = 28\text{ V}; f = 1\text{ MHz}$	–	75	–	pF
$C_{rs}$	feedback capacitance	$V_{GS} = 0; V_{DS} = 28\text{ V}; f = 1\text{ MHz}$	–	7	–	pF
F	noise figure (see Fig.14)	input and output power matched for: $I_D = 1\text{ A}; V_{DS} = 28\text{ V}; P_L = 30\text{ W};$ $R_1 = 1\text{ k}\Omega; T_h = 25\text{ }^\circ\text{C}; f = 175\text{ MHz}$	–	2	–	dB



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## APPLICATION INFORMATION FOR CLASS-B OPERATION

$T_h = 25\text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0.3\text{ K/W}$ ;  $R1 = 1\text{ k}\Omega$ .

RF performance in CW operation in a common source class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_D$ (%)	Z <sub>i</sub> ( $\Omega$ ) (note 1)	Z <sub>L</sub> ( $\Omega$ )
CW, class-B	175	28	50	30	> 13 typ. 15.5	< 50 typ. 67	2.0 - j2.7	3.9 + j4.4
	175	12.5	50	12	typ. 12	typ. 66	2.4 - j2.5	3.8 + j1.3

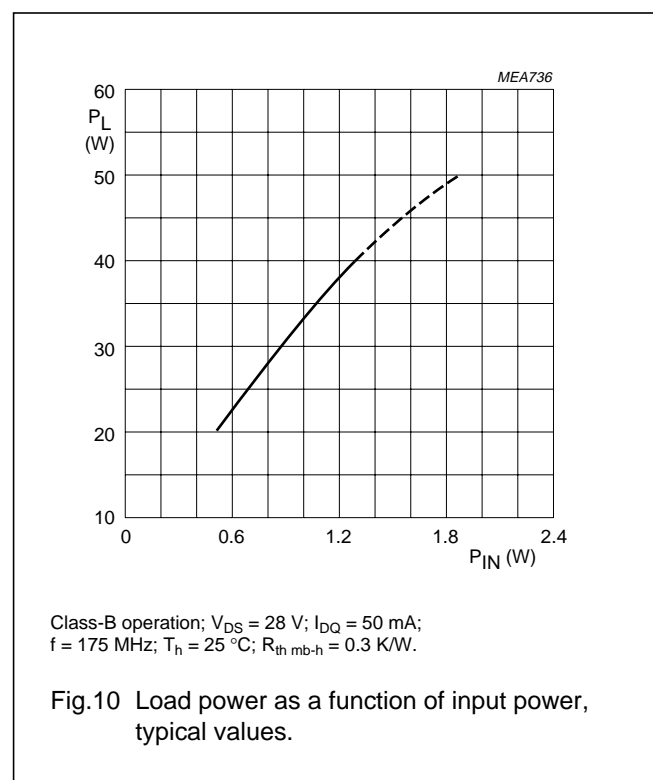
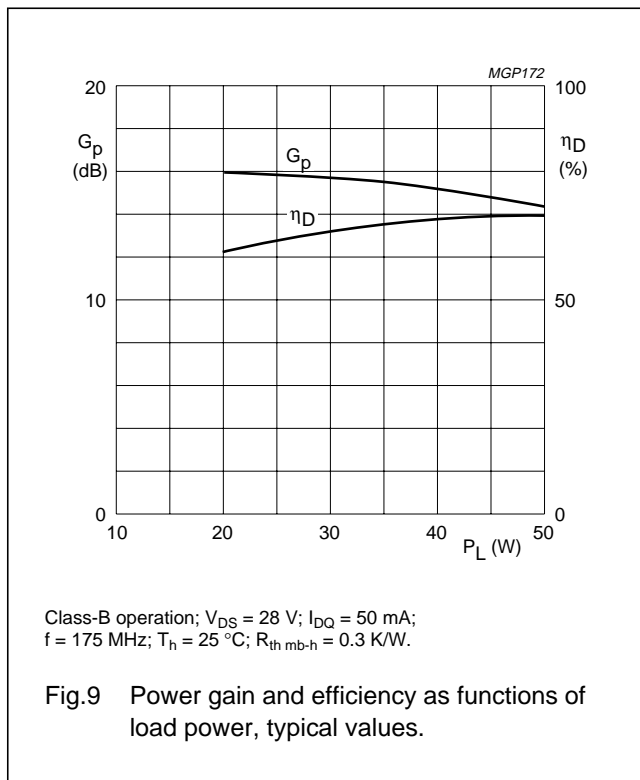
### Note

1. R1 included.

### Ruggedness in class-B operation

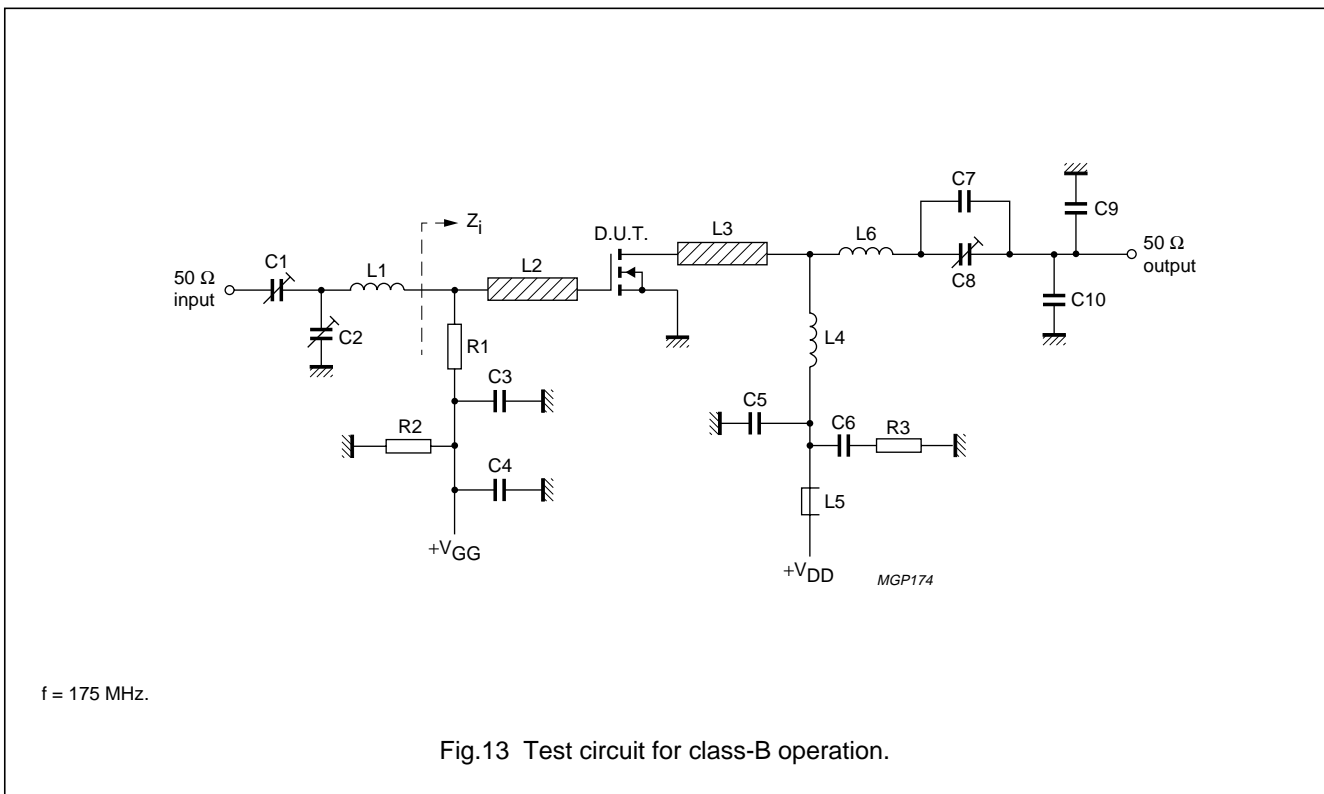
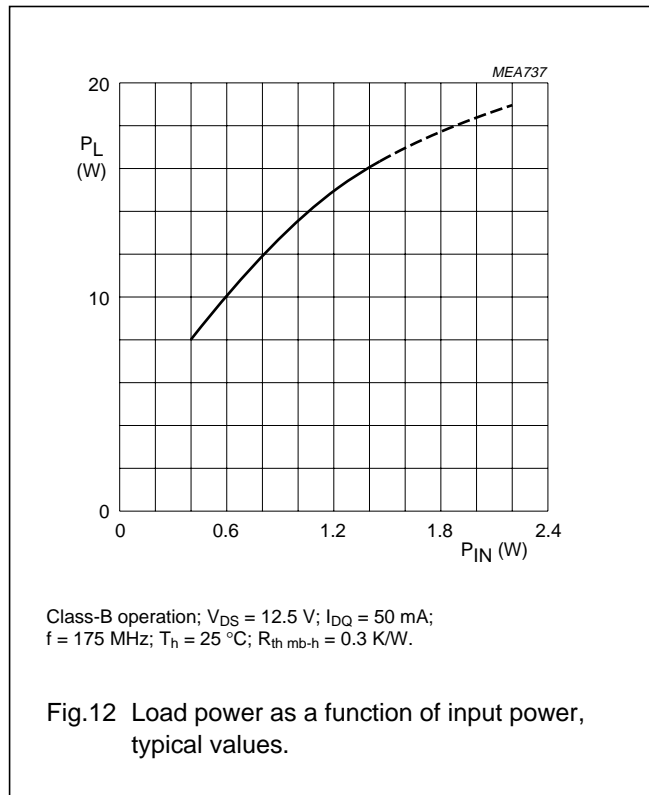
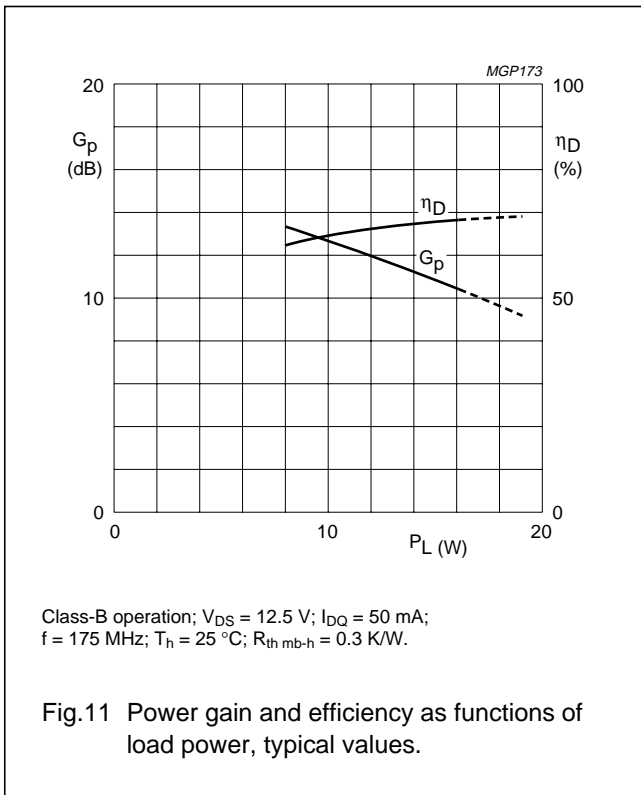
The BLF245 is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases under the following conditions:

$T_h = 25\text{ }^\circ\text{C}$ ;  $R_{th\text{ mb-h}} = 0.3\text{ K/W}$ ; at rated load power.



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## List of components (class-B test circuit)

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	film dielectric trimmer	4 to 40 pF		2222 809 07008
C2, C8	film dielectric trimmer	5 to 60 pF		2222 809 07011
C3	multilayer ceramic chip capacitor	100 pF		2222 854 13101
C4, C6	multilayer ceramic chip capacitor	100 nF		2222 852 47104
C5	ceramic capacitor	100 pF		2222 680 10101
C7	multilayer ceramic chip capacitor (note 1)	18 pF		
C9	multilayer ceramic chip capacitor (note 1)	27 pF		
C10	multilayer ceramic chip capacitor (note 1)	24 pF		
L1	3 turns enamelled 0.5 mm copper wire	13.5 nH	length 3.5 mm int. dia. 2 mm leads 2 × 2 mm	
L2, L3	stripline (note 2)	30 Ω	10 × 6 mm	
L4	6 turns enamelled 1.5 mm copper wire	98 nH	length 12.5 mm int. dia. 5 mm leads 2 × 2 mm	
L5	grade 3B Ferroxcube RF choke			4312 020 36640
L6	2 turns enamelled 1.5 mm copper wire	24.5 nH	length 4 mm int. dia. 5 mm leads 2 × 2 mm	
R1	metal film resistor	1 kΩ		
R2	metal film resistor	1 MΩ		
R3	metal film resistor	10 Ω		

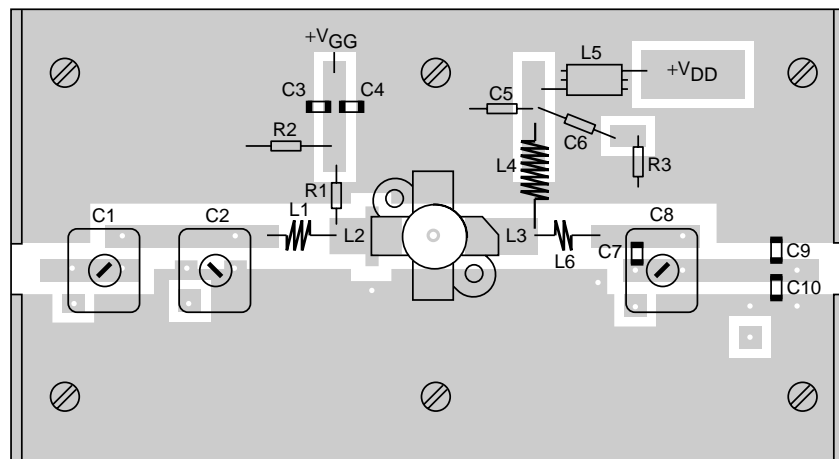
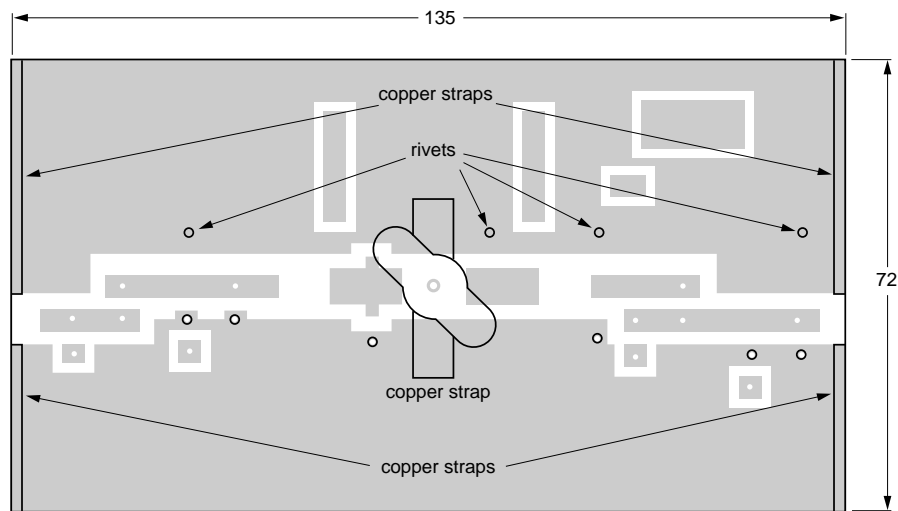
## Notes

1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
2. The striplines are mounted on a double copper-clad PCB with epoxy fibre-glass dielectric ( $\epsilon_r = 4.5$ ), thickness  $\frac{1}{16}$  inch.



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MGP175

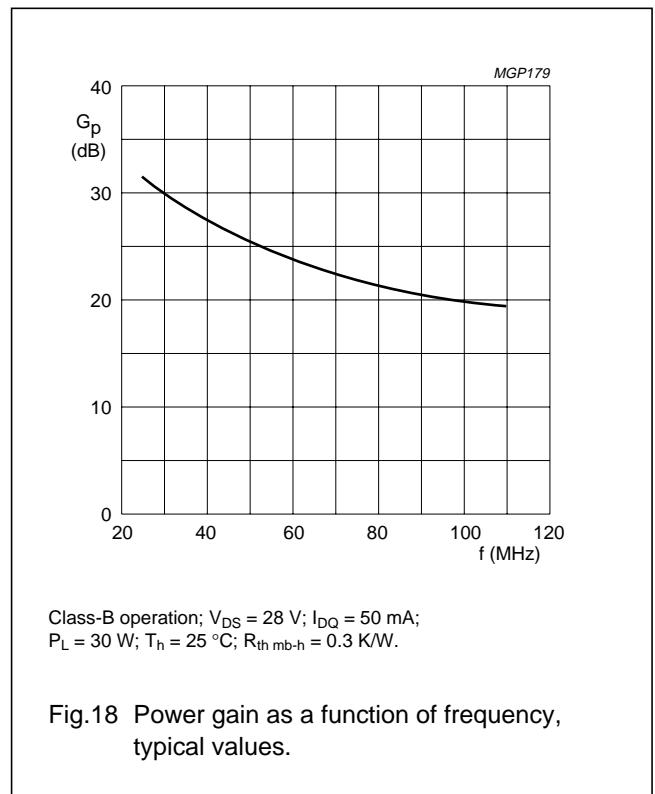
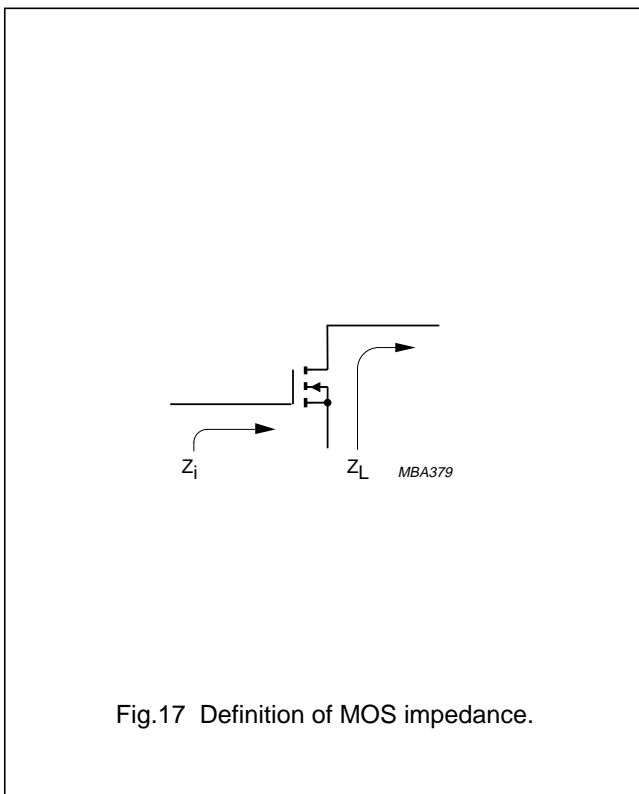
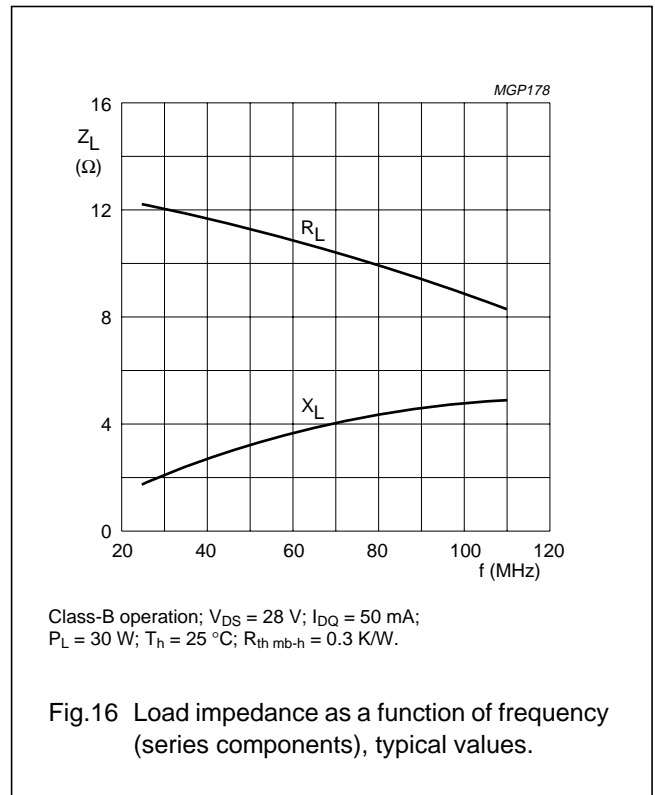
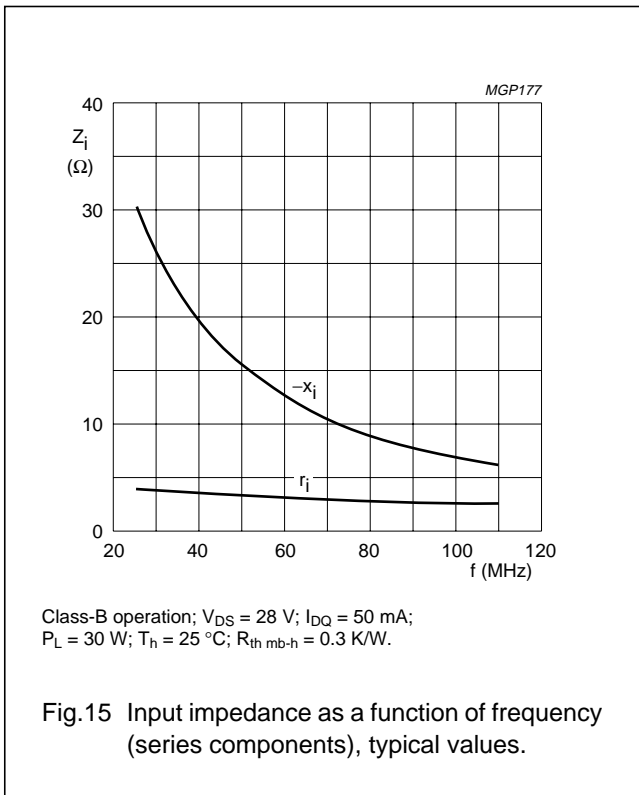
The circuit and components are situated on one side of the epoxy fiber-glass board; the other side is unetched copper and serves as an earth. Earth connections are made by means of fixing screws, hollow rivets and copper straps under the sources and around the edges, to provide a direct contact between the copper on the component side and the ground plane.

Dimensions in mm.

Fig.14 Component layout for 175 MHz class-B test circuit.

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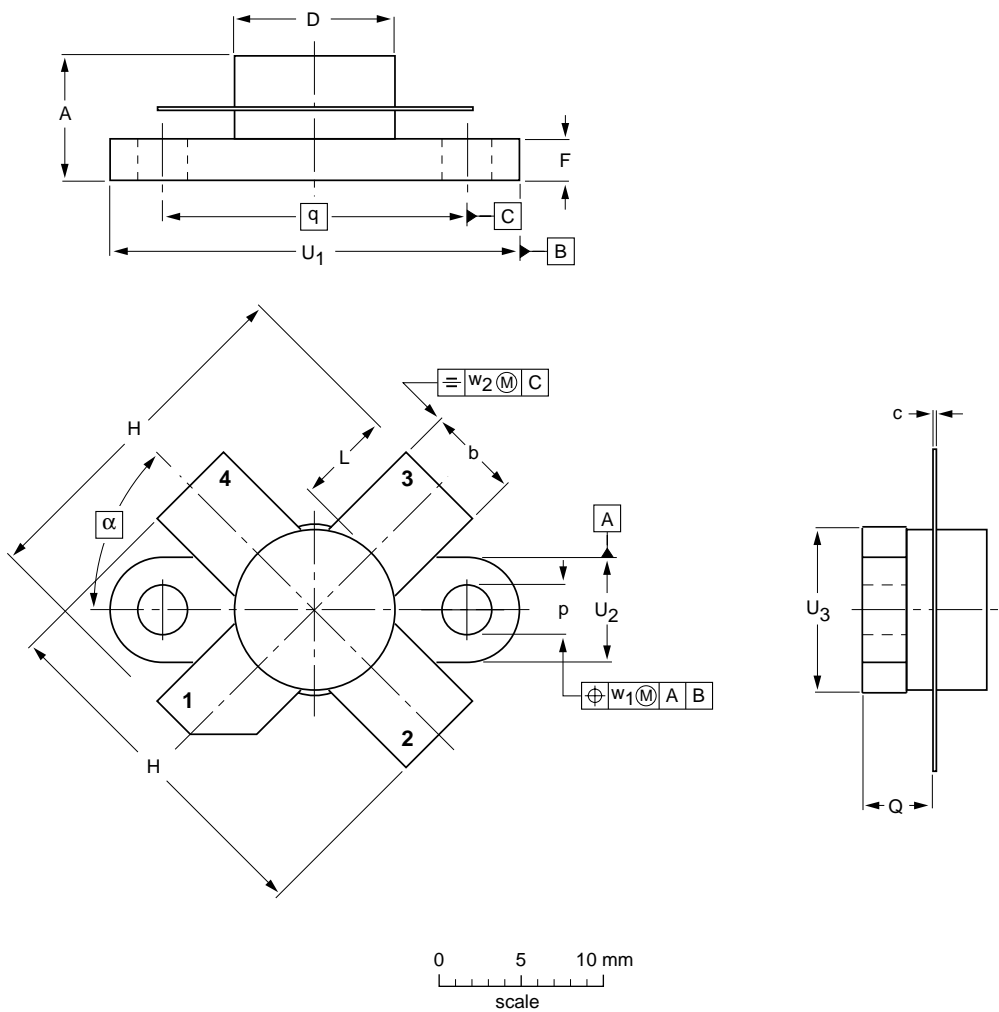
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PACKAGE OUTLINE

Flanged ceramic package; 2 mounting holes; 4 leads

SOT123A



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	c	D	D <sub>1</sub>	F	H	L	p	Q	q	U <sub>1</sub>	U <sub>2</sub>	U <sub>3</sub>	w <sub>1</sub>	w <sub>2</sub>	α
mm	7.47 6.37	5.82 5.56	0.18 0.10	9.73 9.47	9.63 9.42	2.72 2.31	20.71 19.93	5.61 5.16	3.33 3.04	4.63 4.11	18.42	25.15 24.38	6.61 6.09	9.78 9.39	0.51	1.02	45°
inches	0.294 0.251	0.229 0.219	0.007 0.004	0.383 0.373	0.397 0.371	0.107 0.091	0.815 0.785	0.221 0.203	0.131 0.120	0.182 0.162	0.725	0.99 0.96	0.26 0.24	0.385 0.370	0.02	0.04	

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT123A						97-06-28

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**DEFINITIONS**

<b>Data Sheet Status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	

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